



Nano Magnetics for Data Applications

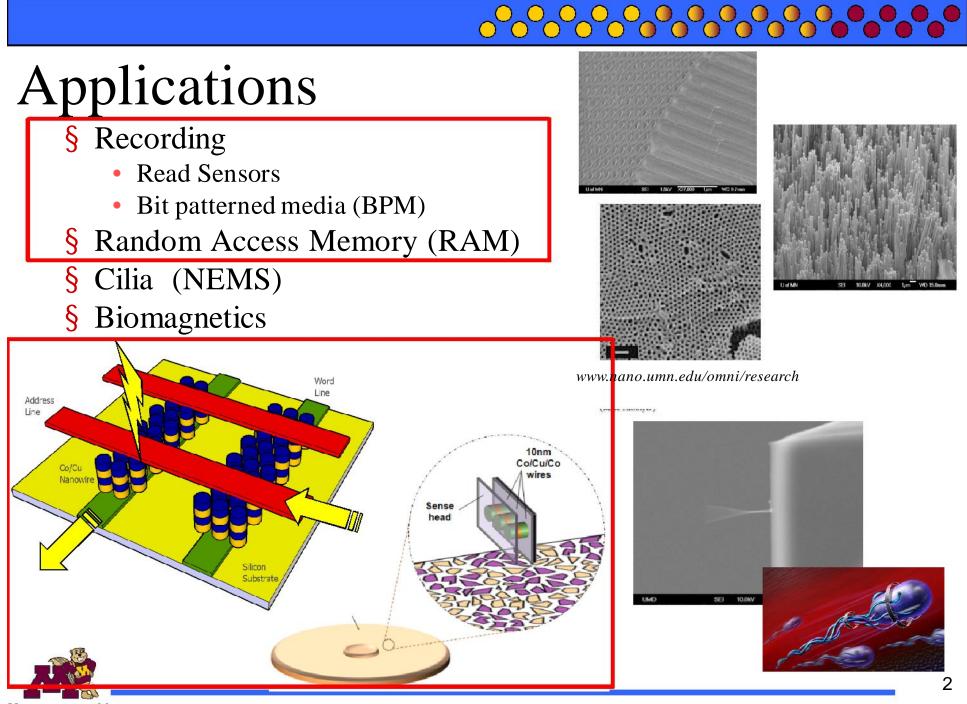


Bethanie J.H. Stadler University of Minnesota

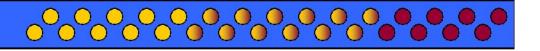
Sang-Yeob Sung, Mazin Maqablah, Anirudh Sharma, Andy Block, Eliot Estrine, Matt Hein

Liwen Tan, Xiaobo Huang, Ryan Cobian, Greg Norby, Madhukar Reddy, Neal Speetzen





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Outine

Ø Motivation: Memory Applications

- **§** Hard drives: media and heads
- **§** Random Access Memories

Ø Fabrication Techniques

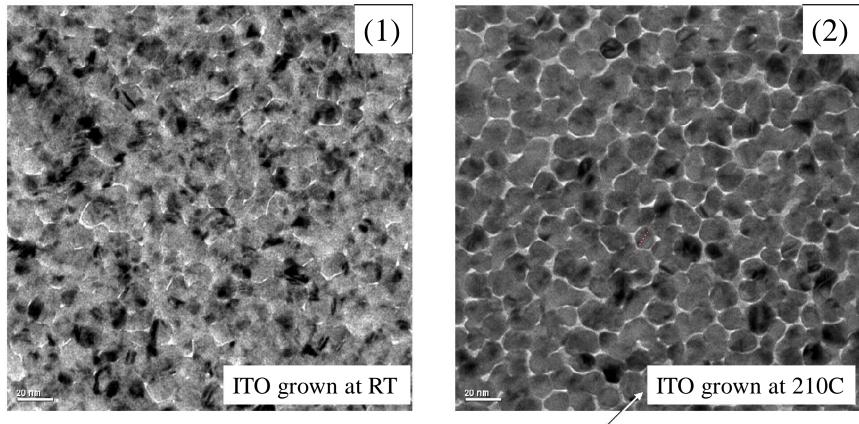
Ø Measuring Magnetoresistive Elements



Neal Speetzen- '06

Which media is better?

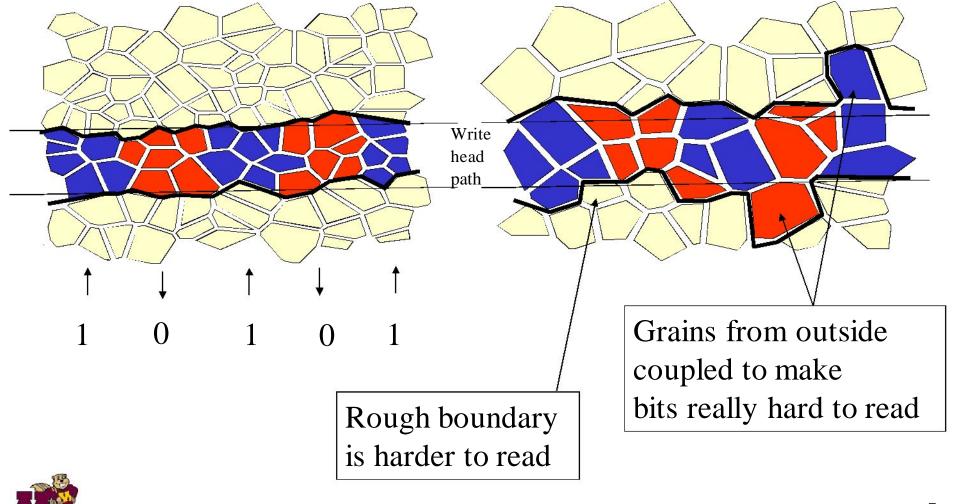
ITO(2nm)/Pd(2nm)/13x[Co(0.26nm)/Pd(1.05nm)]



- Smaller grains (each like a nano-sized bar magnet)
- Not coupled (if one switches, the ones around it won't)
- Bits can have smooth edges (better recording and reading)



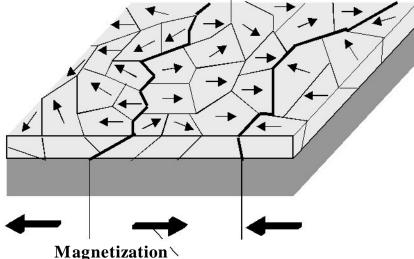
Now which is better?



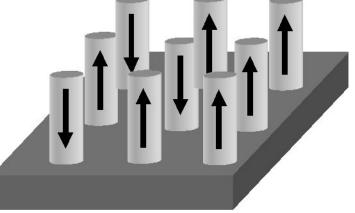


Patterned media may be needed in future

Conventional magnetic thin-film medium



Magnetization transition Net magnetization of the film Patterned magnetic medium with perpendicular magnetization





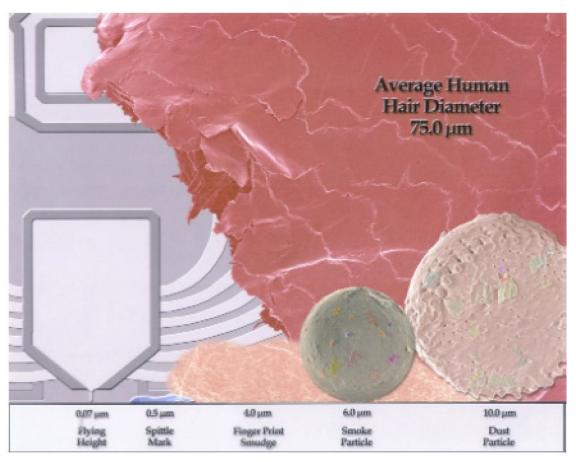


Recording Trilemma

Ø Thermal stabilty= K_uV/kT

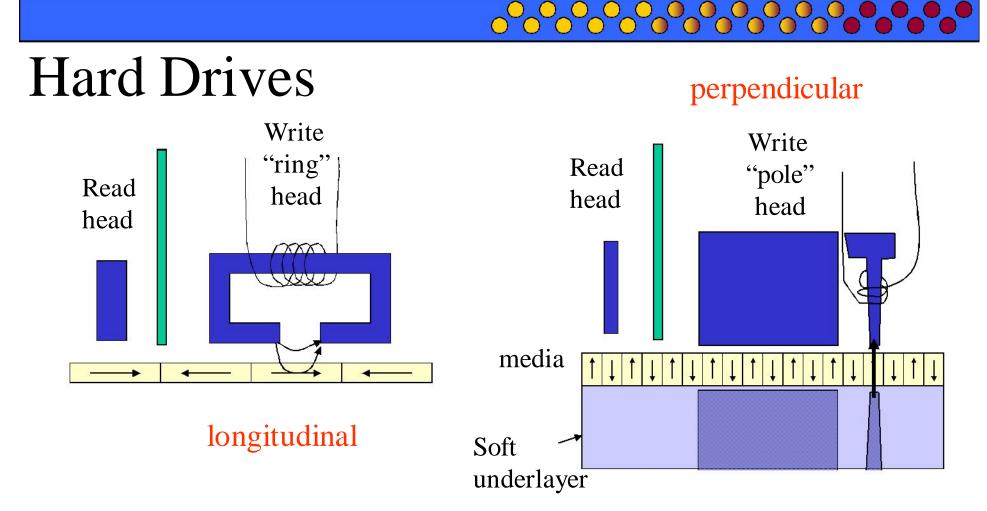
Ø Coercivity must go up if volume is to go down

Ø But, then hard to write





Seagate.com

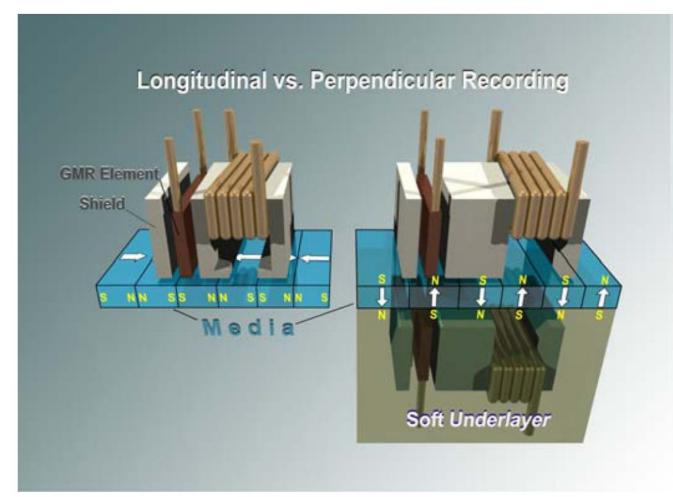


Perpendicular recording media has replaced longitudinal media because the bits can be smaller (in surface area) while maintaining volume, which keeps bits from decaying

http://www.hitachigst.com/hdd/research/recording_head/pr/PerpendicularAnimation.html



Longitudinal vs Perpendicular

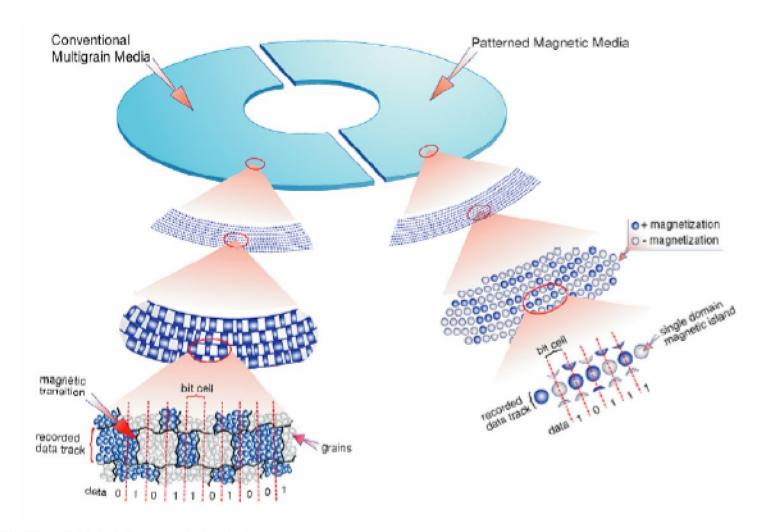




Seagate.com

Conventional Media vs. Patterned Media

HITACHI Inspire the Next

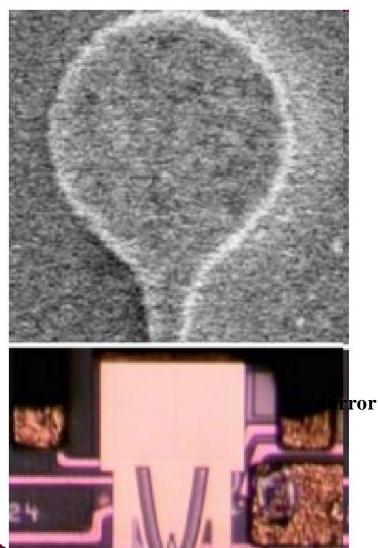


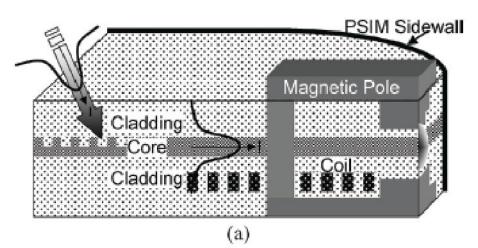
© 2004 Hitachi Global Storage Technologies

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Write Heads

Heat-Assisted Magnetic Recording (HAMR)





Seigler et al IEEE-MAG 08

MIT Tech Review

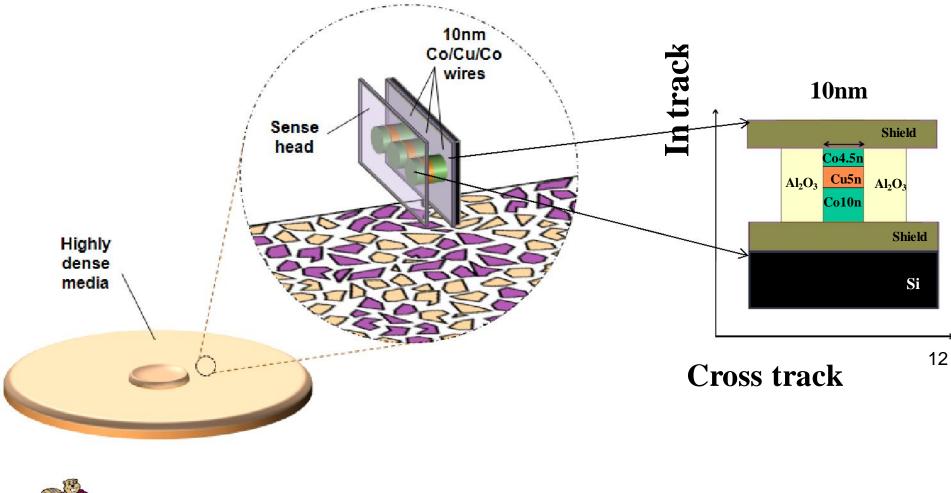




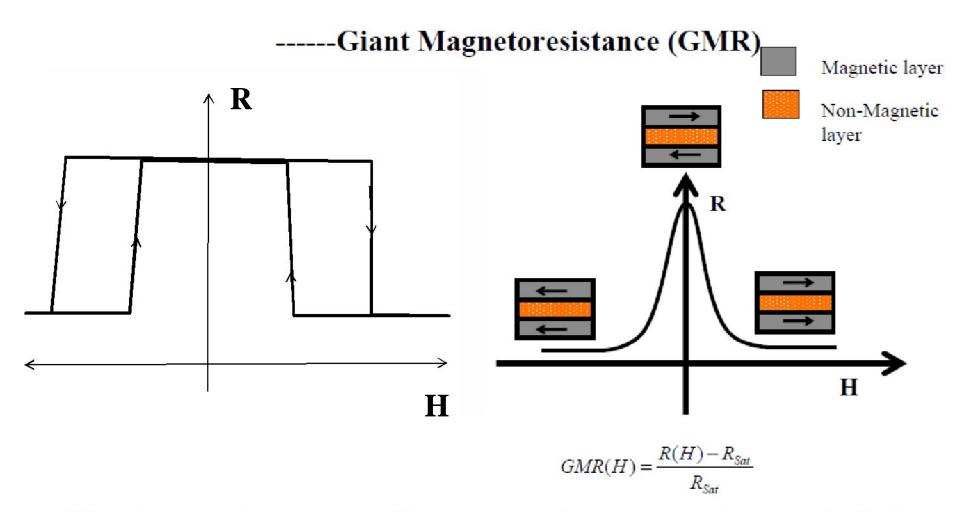
Read Heads

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Typically one per slider, but arrays would help 2D MR



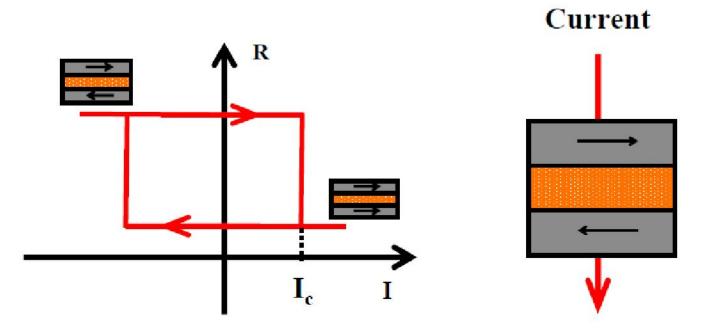
Stadler et al IEEE Transactions on Magnetics (2012). DOI: 10.1109/TMAG.2011.2174975



The change of resistance of a conductor in an external magnetic field.



----Spin Transfer Torque (STT)



Switching current ,Ic is about 107A/cm2



TMR vs GMR

Ø Tunneling magnetoresistive (TMR) sensors

- § Good for today: bits ~15 nm x 75 nm
- § Magnetoresistances: $MR = ?R_{magnet}/R \sim 70\%$.
- § Integration prefer resistances (R) below 300 O
- § Resistance-area (RA) must continuously decrease <<1?. μ m²
 - signal-to-noise ratios (SNR)
 - RC time
 - Heat dissipation to reduce stochastic shot noise as areas decrease
- Ø Current perpendicular to the plane *giant* magnetoresistive (CPP GMR) sensors
 - **§** calculated to have high signal to noise ratios
 - § nanoparticle BPM densities (1-10 Tb/in²)
 - **§** head sizes below 40 nm





Random Access Memory (RAM)

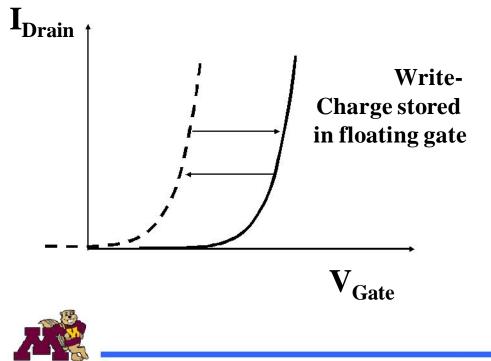
Meet the Competition...

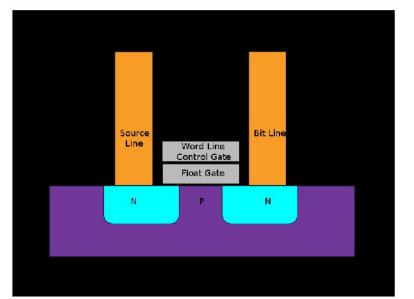
Note: good review in recent MRS Bulletin

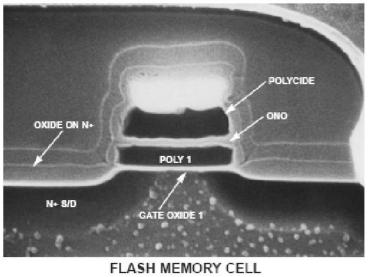


Flash

- Ø Flash = EPROM but erase in blocks (in a "flash")
- EEPROM erases individual bits, but slow and 2 transistors are required







Photos by ICE, "Memory 1997"

22482

Integrated Circuit Engineering Córp

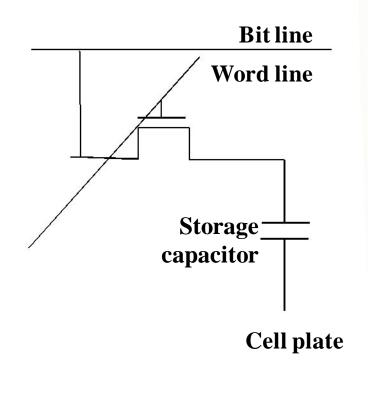
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DRAM (dynamic)

Nanotechnology: Information Technology I (Ed. Waser)

ØCharge stored in a capacitor



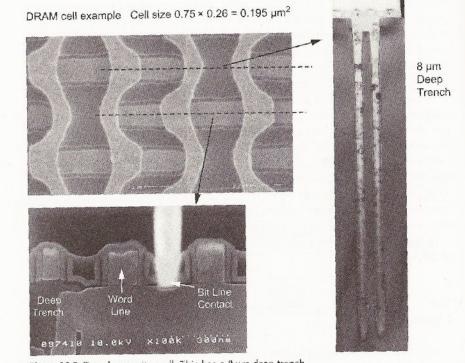
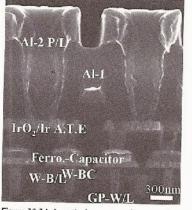


Figure 12.3 Trench capacitor cell. This has a 8 µm-deep trench capacitor and a sidewall storage-node contact for enough storage capacitance and small contact within a small area. (After Yamada, VLSt Tech. Short Course 2003 and Ref. [3]).





Ferro-electric (FeRAM)

ØNon-volatile DRAM

ØNon-volatile capacitor

Figure 13.14 A vertical scanning electron microscopy image of the FRAM cell.

carried out. Due to technical difficulties in realizing a ferroelectric film with low thermal budget processes, and of identifying a suitable oxidation barrier metal which is stable above 600 °C, the early FRAMs were developed with a CUB cell structure, thereby sacrificing cell size efficiency.

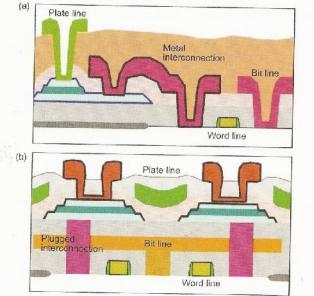
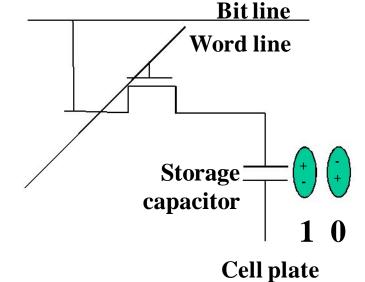
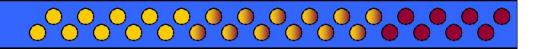


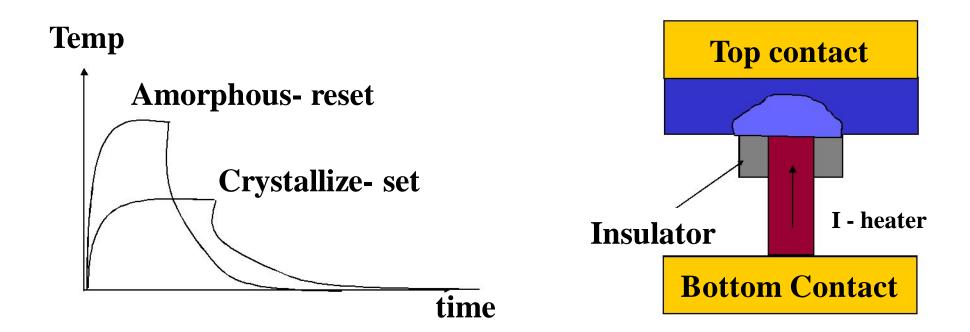
Figure 13.15 Schematic diagram of (a) capacitor under bit line (CUB) and (b) capacitor over bit line (COB) cell structures.



Nanotechnology: Information Technology I (Ed. Waser)



Phase Change Memories



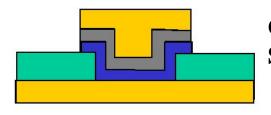
Three orders of magnitude difference in R (cm crystalline, m cm amorphous)



Nanotechnology: Information Technology I (Ed. Waser)

Solid Electrolyte Memory

- \oslash Anode: Ag \rightarrow Ag⁺ + e⁻
- ${\it O}$ Cathode: $Ag^+ + e^- \rightarrow Ag$
- Ø Metal electrodeposits across electrolyte in "snakes"
- Ø Or redissolves with opposite polarity



Oxidizable electrode Solid Electrolyte

Inert Electrode

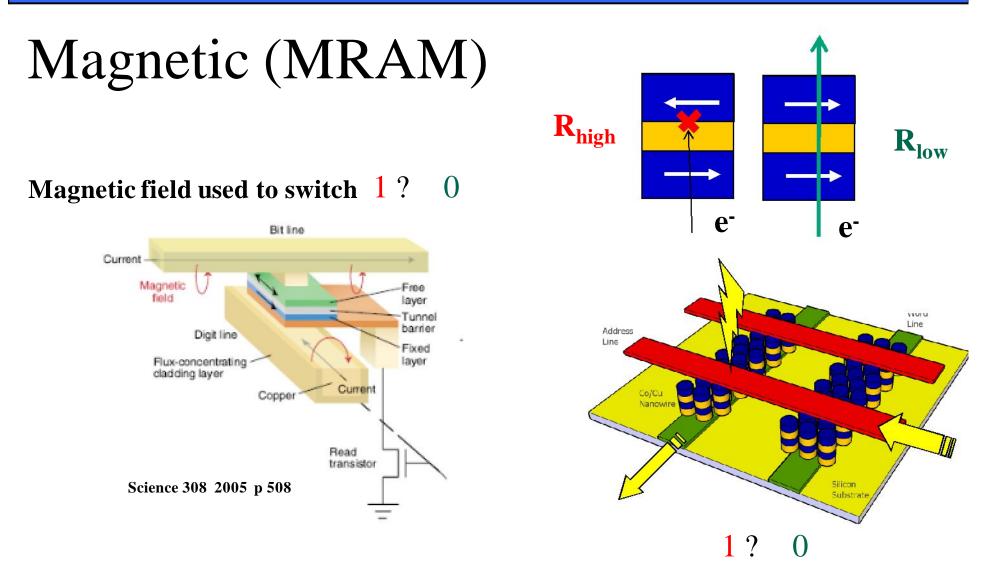




Back to Nano Magnetics.....

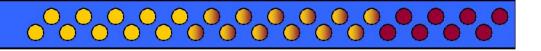


<u>_____</u>



Spin Transfer Torque (STT RAM) Simpler structure to switch with current instead of field also less likely to switch other elements accidentally





Outine

Ø Motivation: Memory Applications

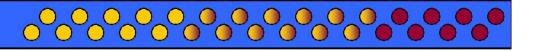
- **§** Hard drives: media and heads
- **§** Random Access Memories

Ø Fabrication Techniques

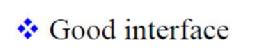
Ø Measuring Magnetoresistive Elements

Ø Conclusions



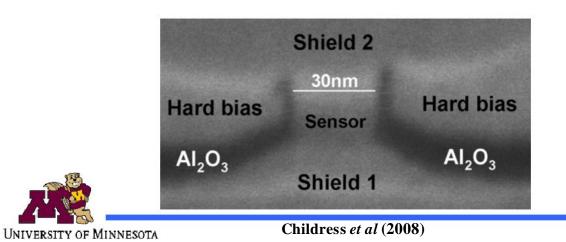


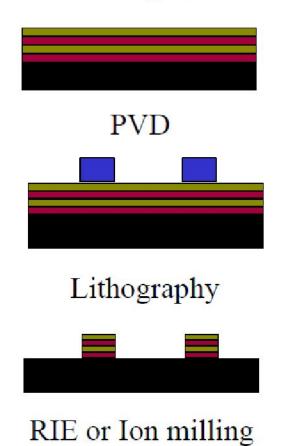
-----Nanostructures by Top-down Technique



High-cost and time-consuming

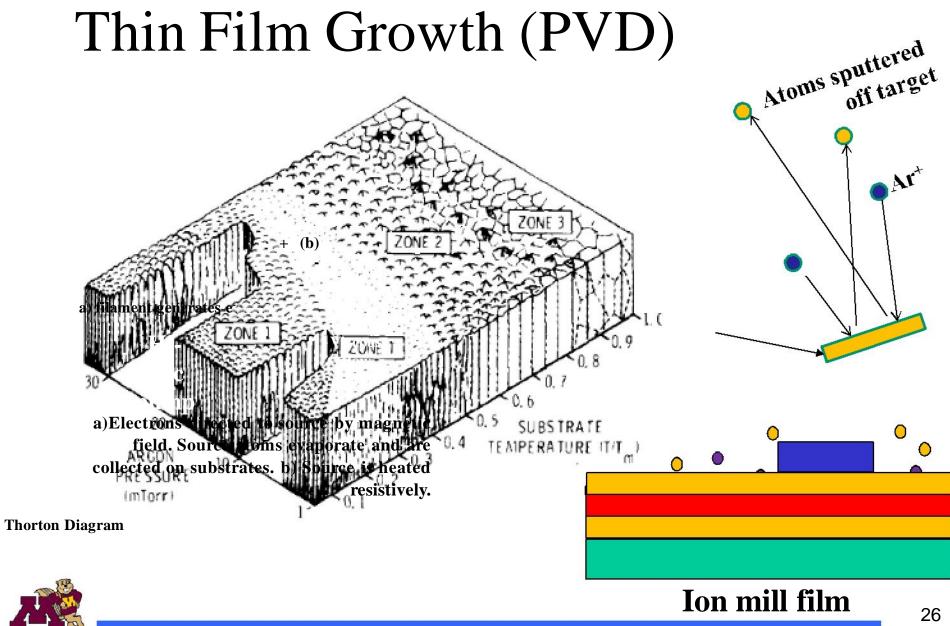
Definition challenges as dimension scaling down





25



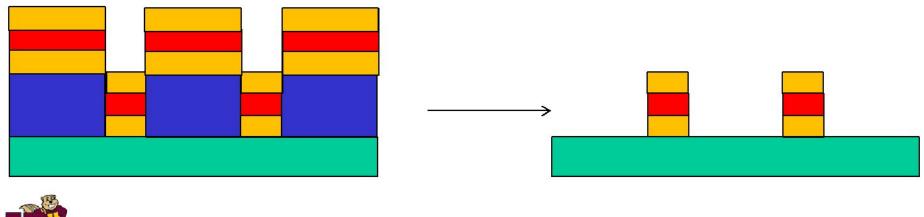


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Top Down- Lift off

ØPattern resist first
ØPVD thin films on top
ØEtch resist so film "lifts off" where you don't want it



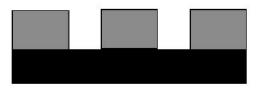


Bottom up Nanofabrication

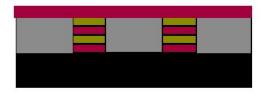
----Nanostructures by Templated Synthesis

Low-cost, high through-put and small diameters (~10nm)

No edge-damage from patterning

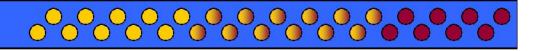


Template with nanopores



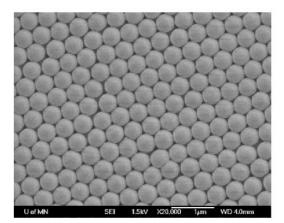
Nanowires deposition

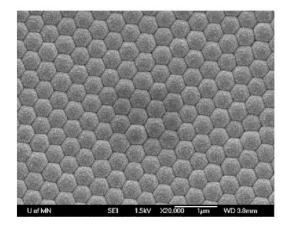
Much more on this later!

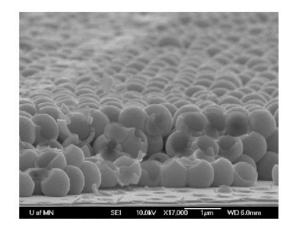


Nanoparticle Assembly

ØVacuum and liquid techniques available to make nanoparticles

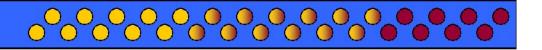






These are mico-particles, but see work for example by Sara Majetich at Carnegie Mellon University for nanoparticles

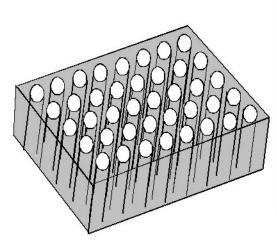




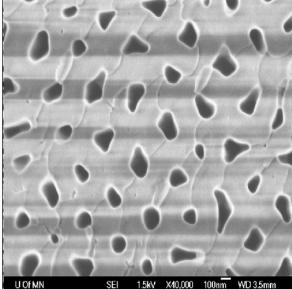
In all but last case... masks/templates are needed



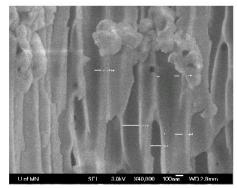
Anodic Alumina Templates- more later

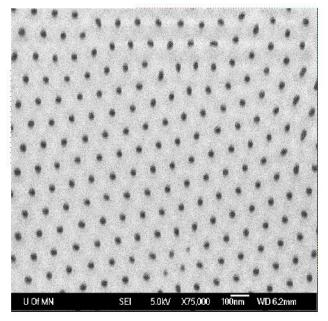


Side View



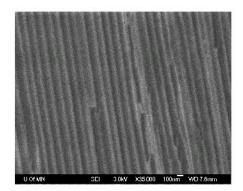
Commercially available alumina template-- No homogeneity or order





Alumina template from our lab-

- Homogeneity & short range order
- No long range order





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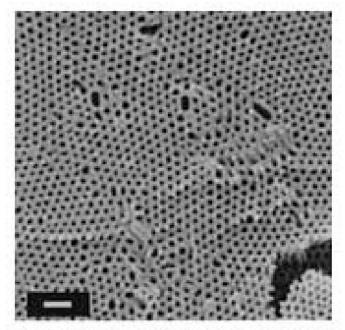
Diblock Copolymers- Overview

Ø Advantages over anodic alumina

- § No barrier layer at the bottom of the asformed pores
- § Ease of dissolution of the template to expose the wires

Ø Disadvantages:

- § limited range of possible diameters
 - 14-50 nm
- § competing interactions that make them more difficult to align completely perpendicular to the substrate



Scanning electron micrograph of a nanoporous block copolymer fracture surface. The PLA block of the PS-PLA copolymer has been degraded to leave behind nanoporous PS. (Mare Hillmyer)

www.nano.umn.edu/omni/research



Etched Ion-Track Polymers

Ø Advantages: smaller number, or lower density, of nanopores can be fabricated

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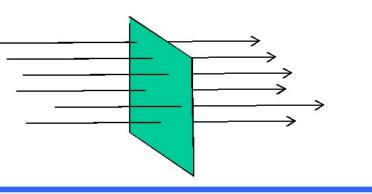
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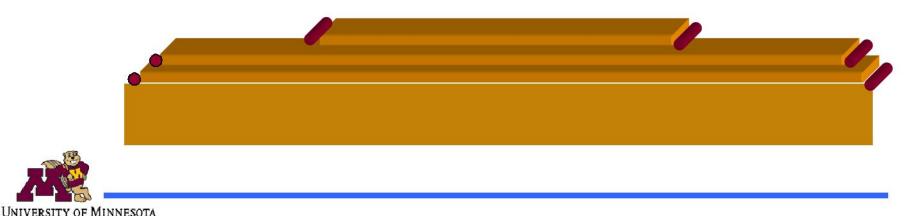
- § Even down to a single nanopore
- **§** Measuring single wires possible with microscopic electrical contacts
- Ø Ion-track templates made by irradiating polymer membranes
 - § Usually polycarbonate 10-50um thick
 - § Heavy ions, such as Ar, Xe, Au or Pb
 - § Energies of 8-12 MeV/nucleon for single ion tracks
 - § 0.2-2 GeV with fluences between 10^6 and 10^9 ions/cm² for multiple tracks
 - § Tracks left by ions chemically etched in aqueous NaOH
 - § Sometimes UV irradiated first
 - § Make pores as small as 15nm





Nanowires Not Discussed Here (1)

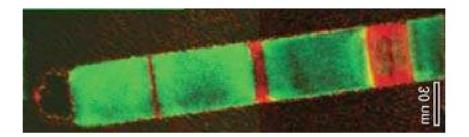
- Ø This talk will focus on inorganic nanowires
 - **§** Metals (some ceramics, semiconductors) not carbon nanotubes
- Arrays are usually grown inside predefined pores of nanometer size
 § Usually grown via electrochemical deposition
- Ø Other techniques used for individual nanowires (Step Growth)
 - § Uses steps on atomically rough substrate & chemical/physical vapor deposition
 - § Essential trade-off is deposition rate versus surface diffusion rate
 - § Growth morphology: stepped surface with nanowires located in the nook of each step
 - § Mostly used for metallic nanowires- adatoms have fast surface diffusion coefficients



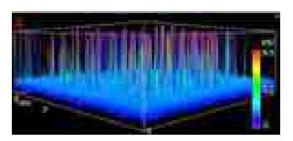
Nanowires Not Discussed Here (2)

Ø Other techniques for arrays (VLS approach)

- § Vapor-liquid-solid technique
- § Liquid drops of catalyst are supersaturated with nanowire elements using vapor source
- **§** Solid wire then crystallizes out of the droplet onto the substrate
- **§** Vapor can be supplied via chemical vapor deposition, laser ablation, thermal evaporation
- § Mostly used to grow semiconductor nanowires due to solubility in liquid-metal catalysts



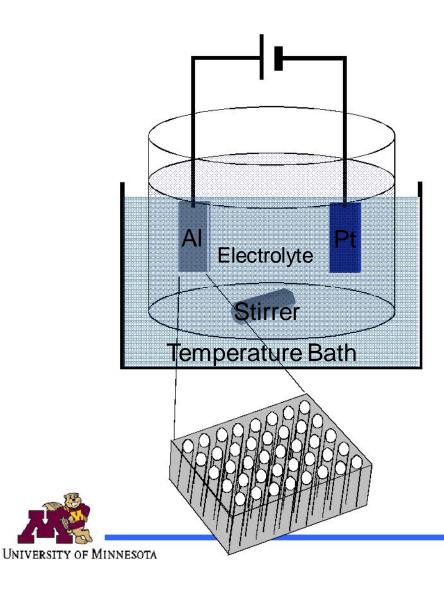
Björk et al./Nano Letters



Zhong Lin Wang et al, Science



Anodization



Nanopores self assemble inside of an oxide film when the oxide is grown by anodizing metallic aluminum.

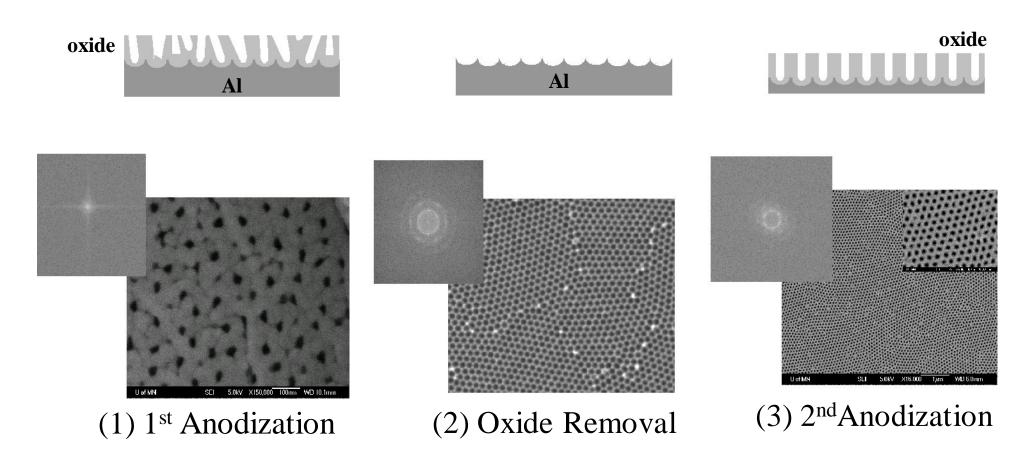
Pore size (diameter)

- ~ 150nm (anodized in phosphoric acid)
 - ~ 50 nm (anodized in oxalic acid)
 - ~ 20 nm (anodized in sulfuric acid)

Aligned range ~ 1~10 μm



Two-step Nanoporous Anodic Alumina

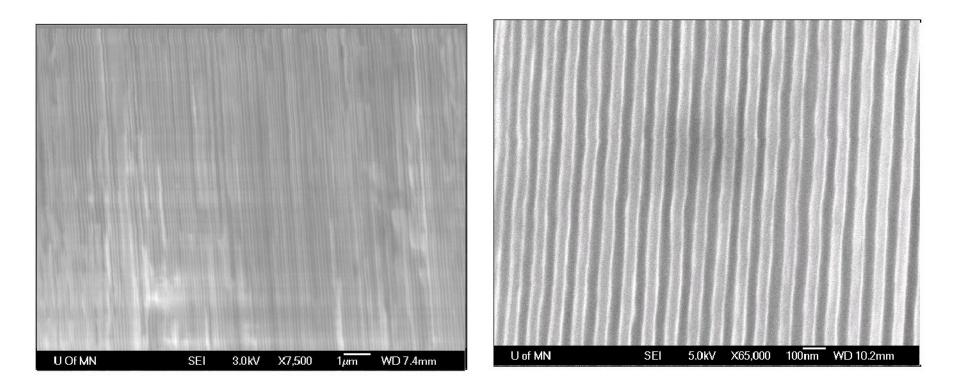




Two-step anodization yields nanopores w/ uniform diameter and spacing



Nanopores are strictly parallel

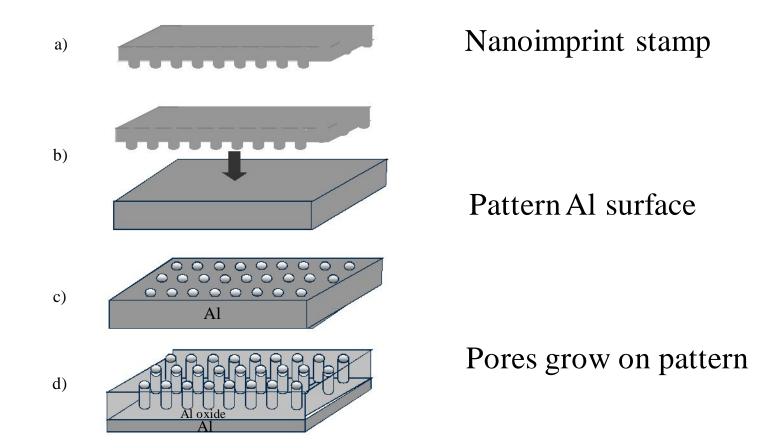


Ghliqueixiew





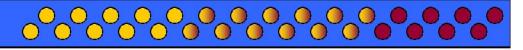
Directing the Self-Assembly



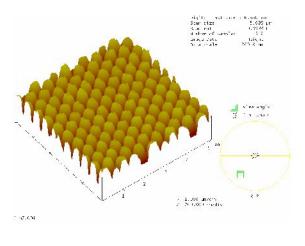
B. J. H. Stadler, Na hyoung Kim, L. Tan, J. Zou, K. Kelchner, R. K. Cobian, Mater. Res. Soc. Symp. Proc. 853E, I6.3 (2005). Fig. 4.3. Process for directed self-assembly of nanopore arrays by nano-imprint H. Masuda, H. Yamada, M. Satoh, and H. Asoh, Appl. Phys. Lett. 71, 2770 (1997) method: a)Master stamp with ordered array of posts, b)Molding on the Al using J. Choi, K. Nielsch, Man Religness, R) patternet reprint and Allocization and gravity of posts, b)Molding on the Al using



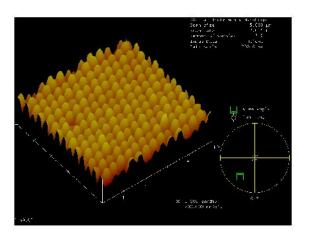
nanopore arrays under particular condition



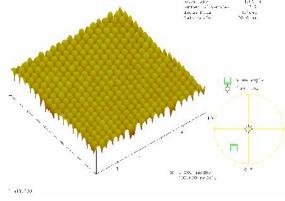
Imprint Stamps



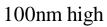
a = 500nm



a = 400 nm



a = 300nm

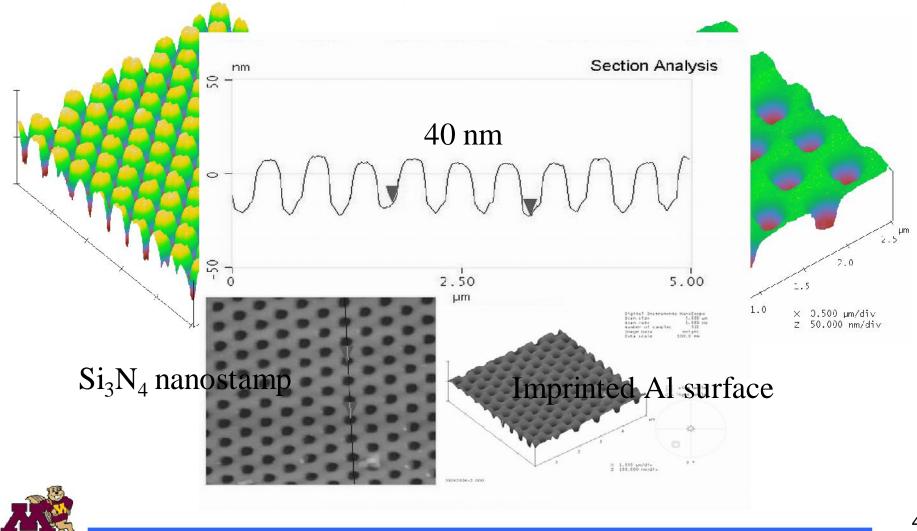


 Si_3N_4 tips (defined by e-beam lithography) can be used to imprint Al to produce aligned pores



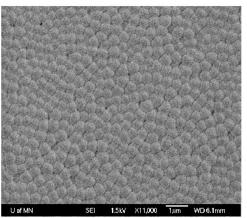


AFM Images

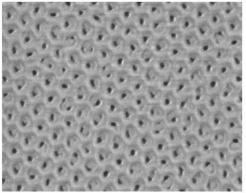


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SEM After Anodization

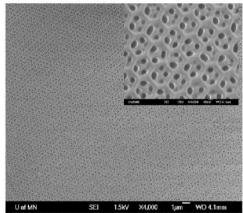


Bottom side of AAO made from nonimprinted AI that was anodized at 180V.

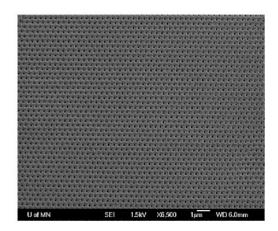


(Top view of AAO formed by anodizing AI that was imprinted with 400nm periodicity at 170V.





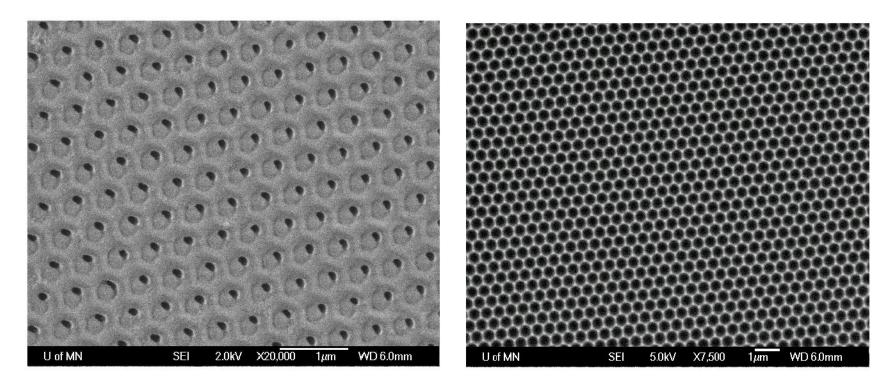
(Top view of AAO formed by anodizing AI that was imprinted with 700nm periodicity at 170V.



Top view of AAO formed by anodizing AI that was imprinted with 400nm periodicity at 180V.



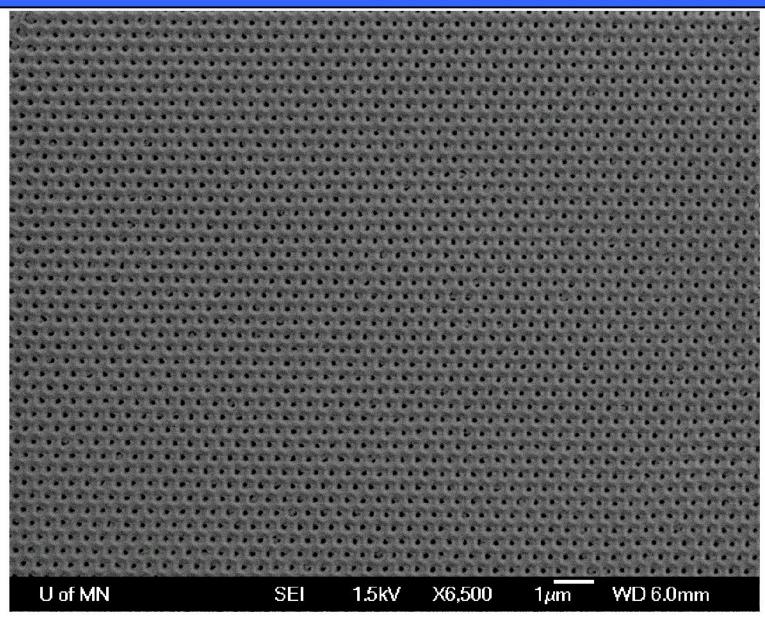
SEM After Anodization



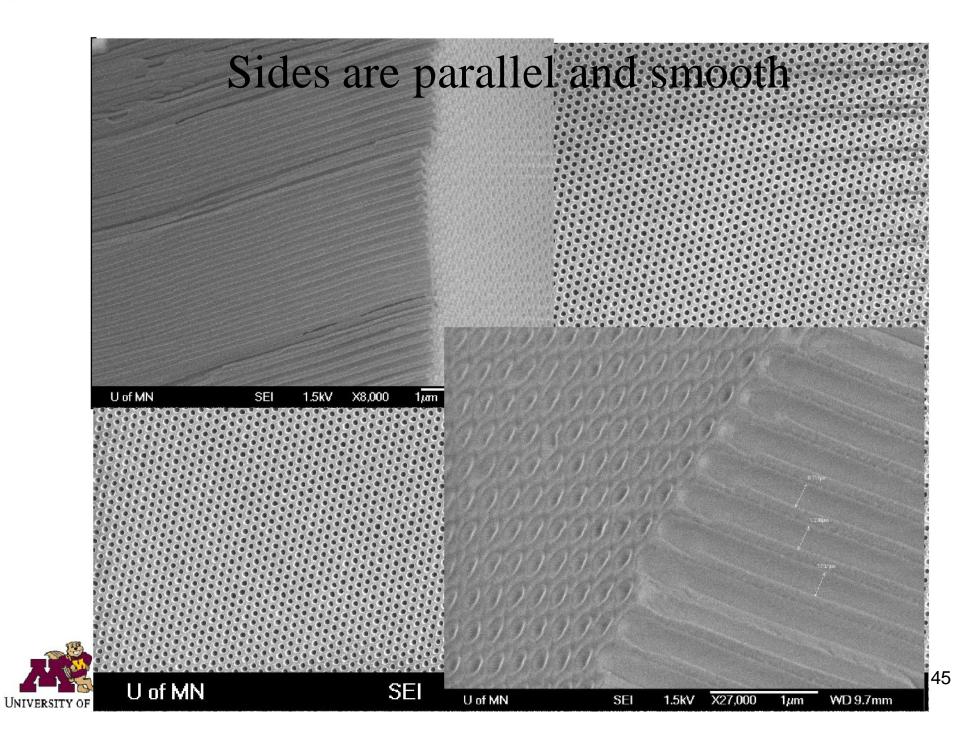
Top view of as-grown oxide

Etched in a solution of phosphoric acid (6wt%) and chromic acid (1.8wt%) at 60°C for 5h to remove oxide and view underlying Al interface with 500nm spacing maintained.

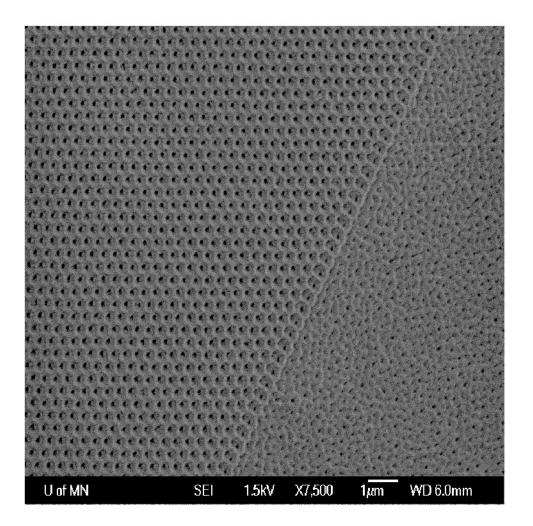






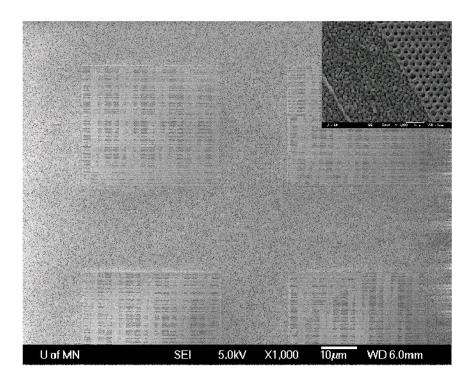


Boundary between Order & Disorder





Boundaries between order and disorder can be used in photolithography

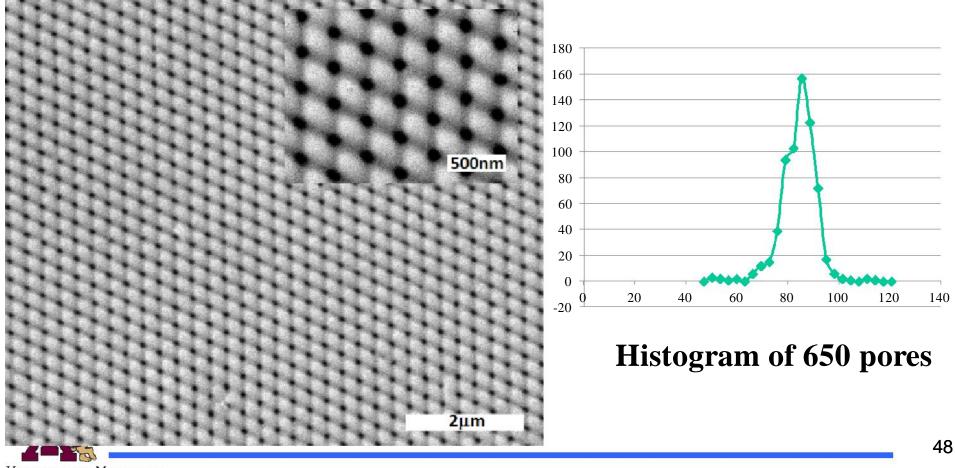


Anodic alumina template with two-scale order by nanoimprint method; insert is the boundary between ordered and disordered regions. SEM image of nanopores with photo resist aligned to block rows of pores; insert zoomed out image of nanowires grown using electrode pattern.

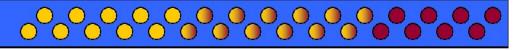


Large Areas (ft²) are possible

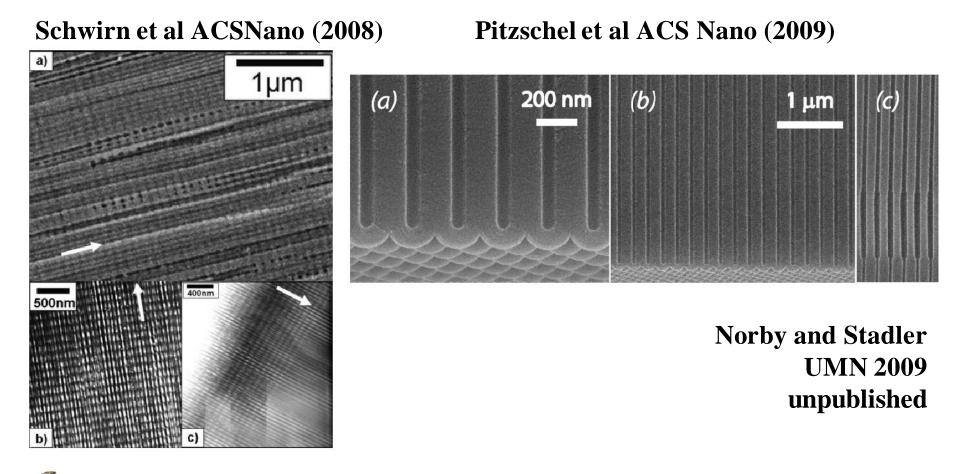
- 83nm diameter (+/- 6.1nm) - Over 1 in² available for \$5 in my lab (not for direct sale :)



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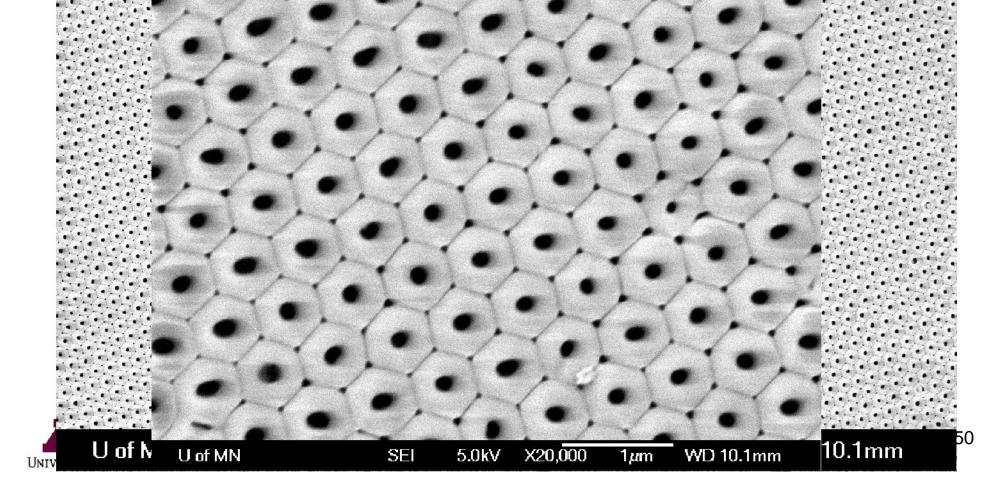


Varying Diameters of Nanopores



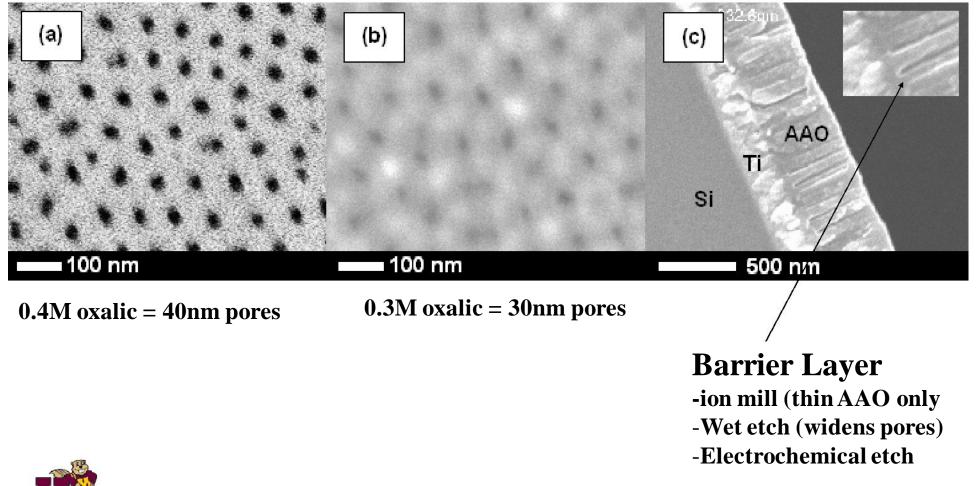


Periodicity Multiplication





AAO on Si

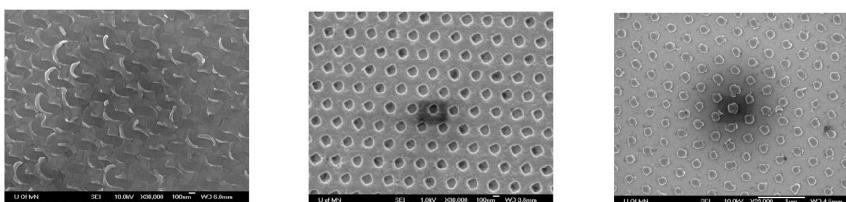




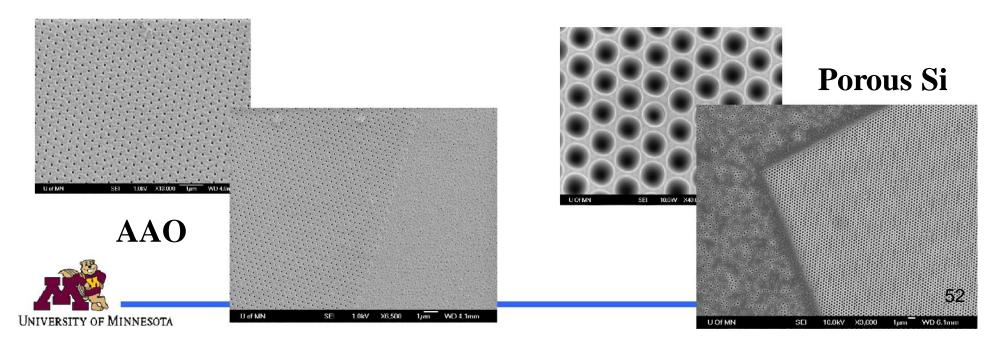


Perfect AAO on Si

Stamp after >30 imprints

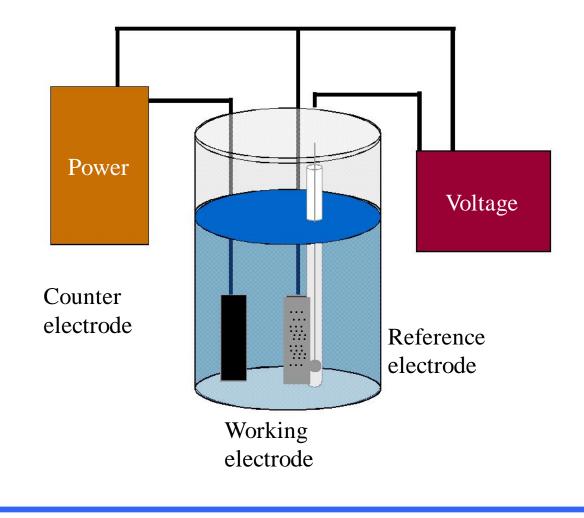


At first stamp slipped, but then it held and was not damaged



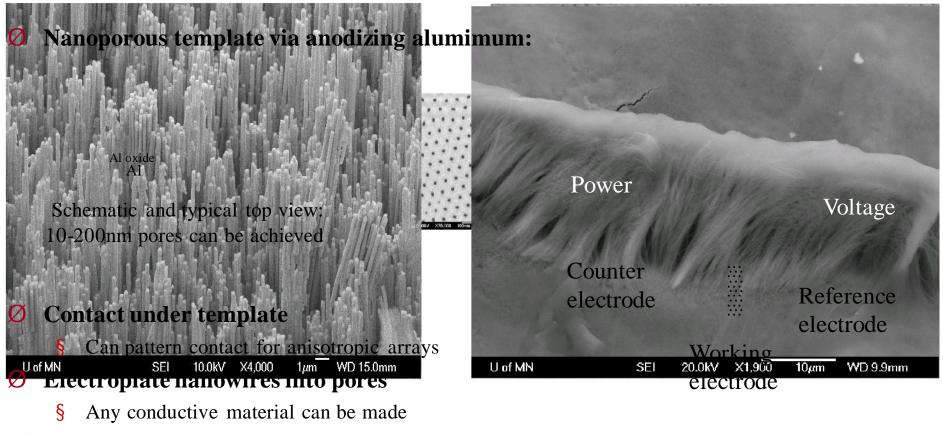


Making Nanowires





Making Nanowires

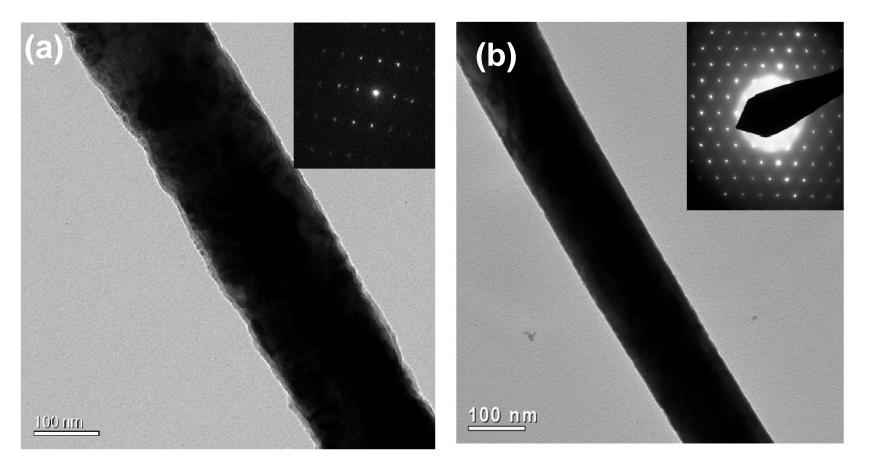


Ø Etch template if application requires





TEM Analysis

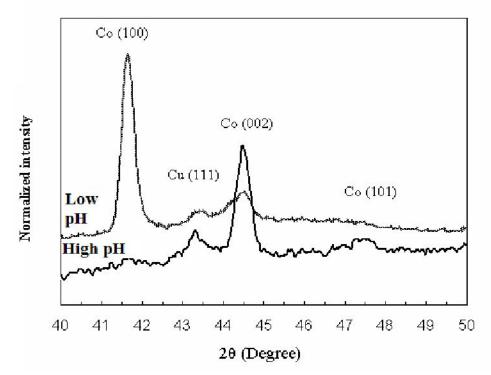


(002) along the wire

(002) Perpendicular to the wire



Control of Co Crystallographic Orientation

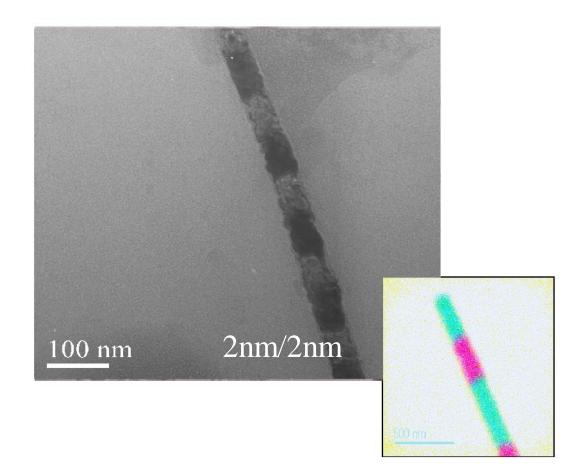


∨ Control pH of the solution to adjust Co caxis alignment

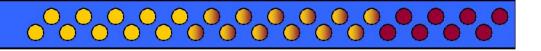
- -- High pH, Co c-axis along wire
- -- Low pH Co c-axis perpendicular to wire



TEM Image of Co/Cu Multilayered Nanowires







Outine

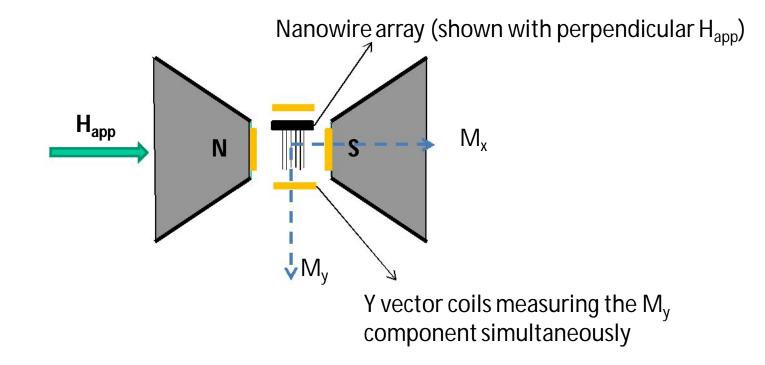
Ø Motivation: Memory Applications

- **§** Hard drives: media and heads
- **§** Random Access Memories
- Ø Fabrication Techniques
- Ø Measuring Magnetoresistive Elements
- Ø Conclusions



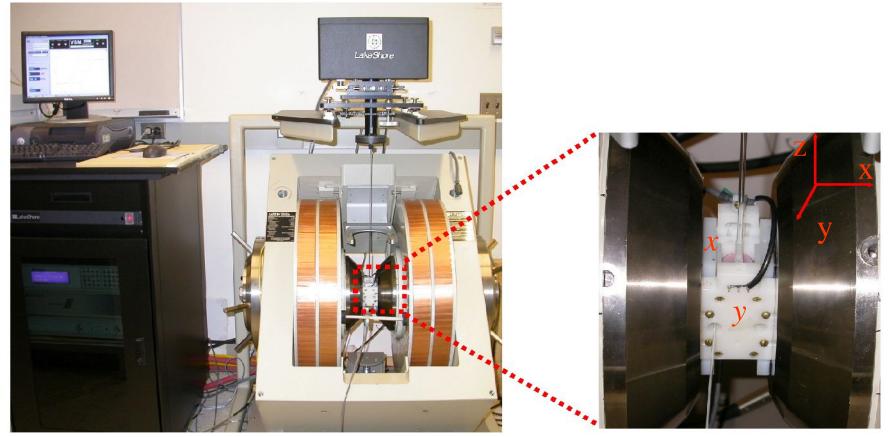


Magnetic Characterization





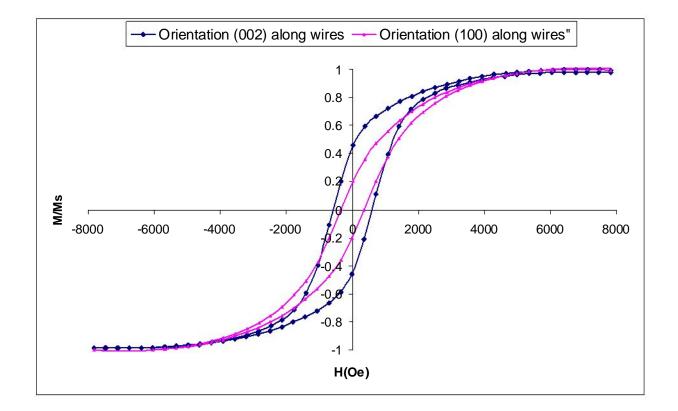
Vibrating Sample Magnetometer (VSM)



 M_x — Magnetic component along magnetic field M_y — Magnetic component perpendicular to magnetic field



M-H Loops of Co nanowires

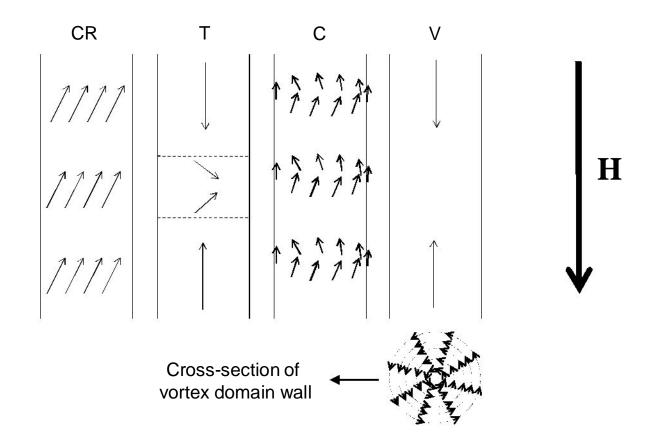


Magnetic field parallel to nanowires (Diameter:150nm)



Magnetization reversal

- what is different for nanomagnetism?



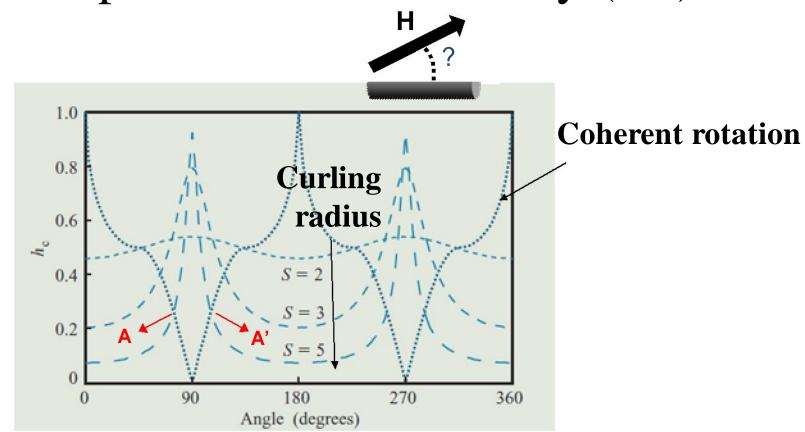
CR: coherent rotation, T: transverse domain wall

C: curling and V: vortex domain wall.



Madhukar Reddy, Advanced Functional Materials (2012)

Angular dependence of coercivity (Hc)



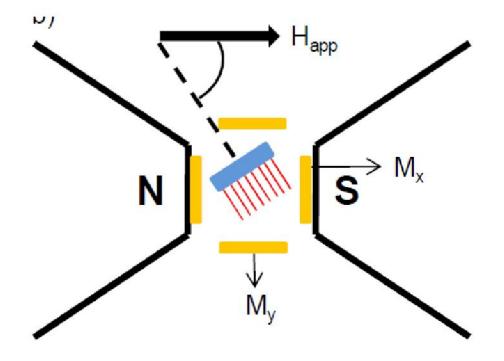
Calculated angular dependence of the reduced coercivity $h_c = H_c/2pM_s$ for $S = r/r_0$, where $r_0 = A^{1/2}/M_s$. For Fe₈₀Ga₂₀, A = 1.8 x 10⁻⁶ erg/cm, M_s = 1353 emu/cm³, and therefore r_0 is ~10 nm radius or ~20 nm diameter.



Adapted from Sun et al IBM J. Res. Dev. 49, 79-102 (2005).



Experimentally

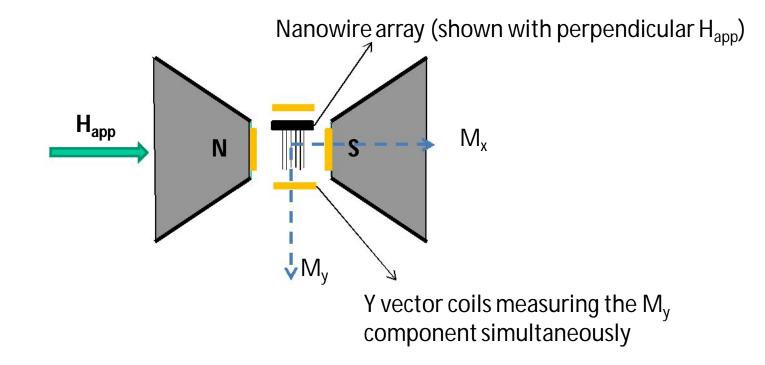




Sample moved, not field

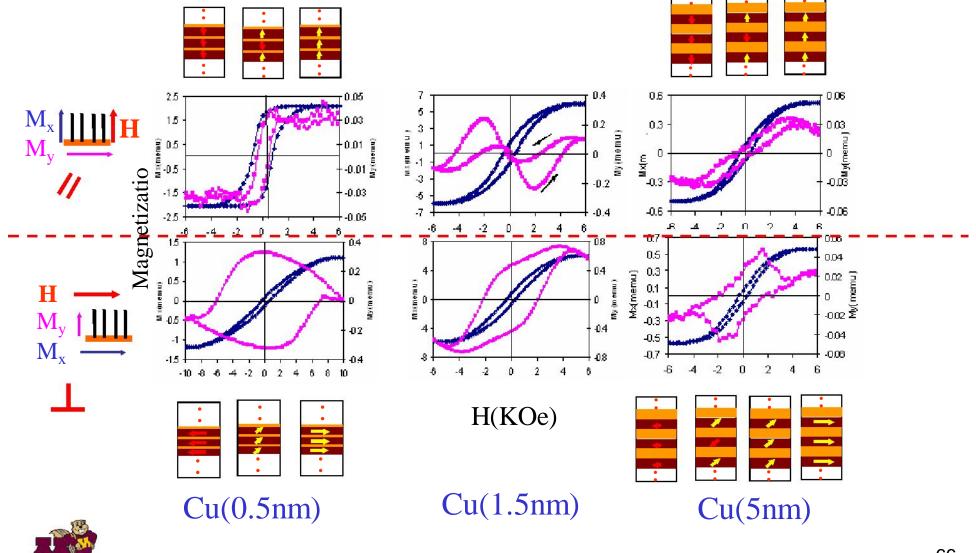


Magnetic Characterization





M-H Loops of Co(5nm)/Cu(xnm) Nanowires





Magneto-transport measurements -magnetic and *electronic* effects

Ø PPMS

§ Same bottom electrode

§ Ag epoxy on top

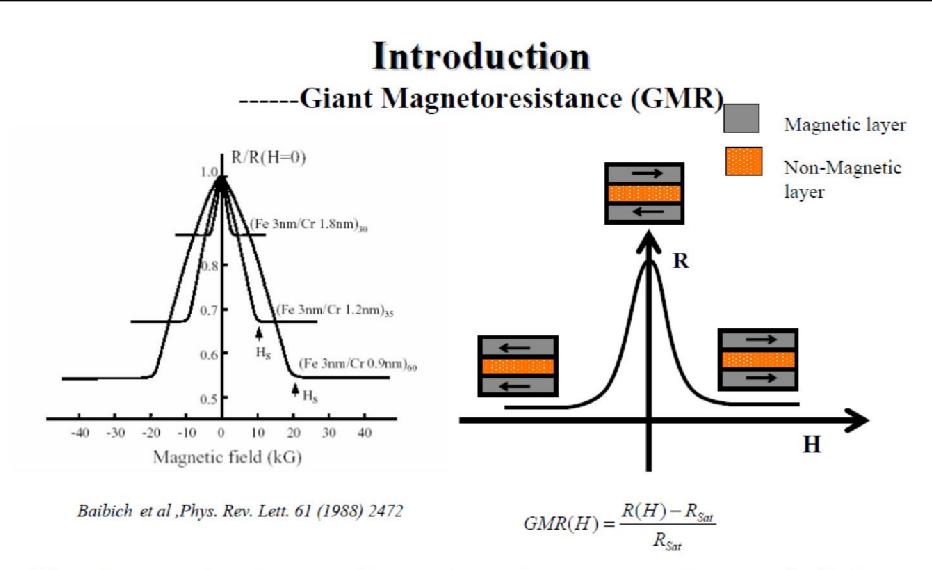
ØHead Tester

§ Two probes on top

ØAFM

- § Conductive AFM probe on top
- § Same electrode



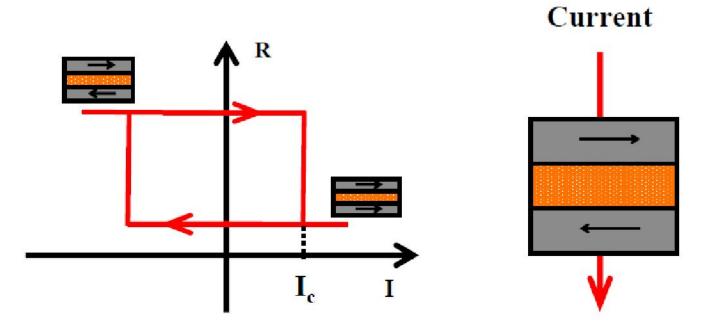


The change of resistance of a conductor in an external magnetic field.



Introduction

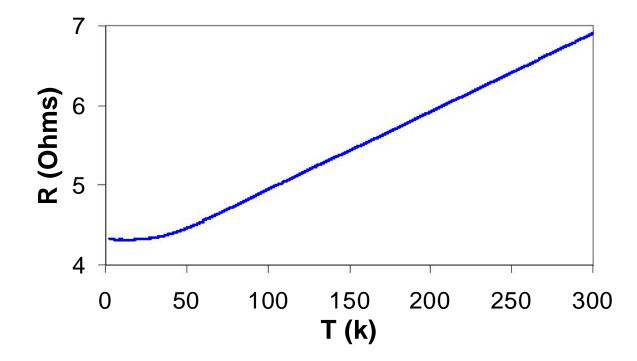
----Spin Transfer Torque (STT)



Switching current ,Ic is about 107A/cm²



Resistance vs. Temperature

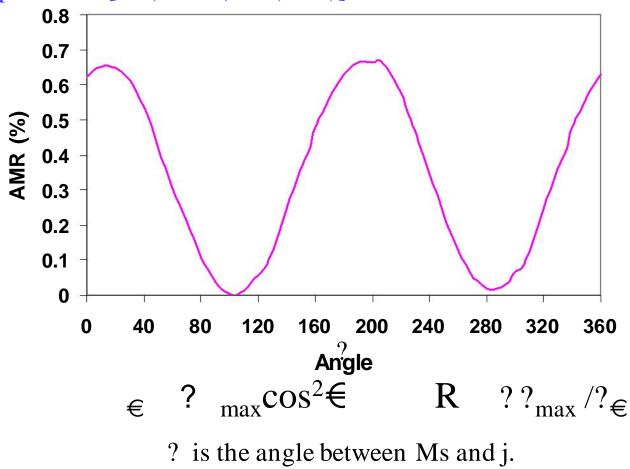


• Multilayered Co/Cu nanowires showed the metallic properties.



Anisotropic Magnetoresistance --AMR

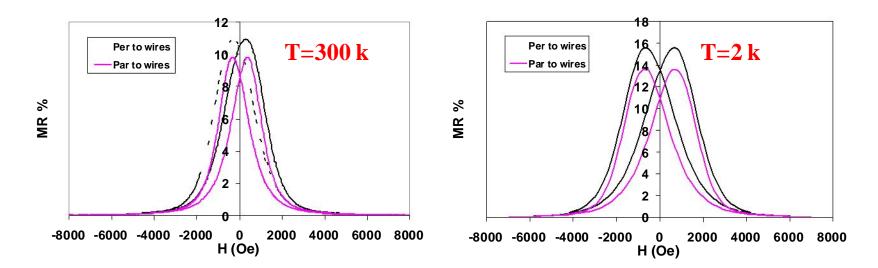
Samples: 300*[Co(27 nm)/Cu(5nm)]







Sample: 300*[Co(27nm)/Cu(5nm)]

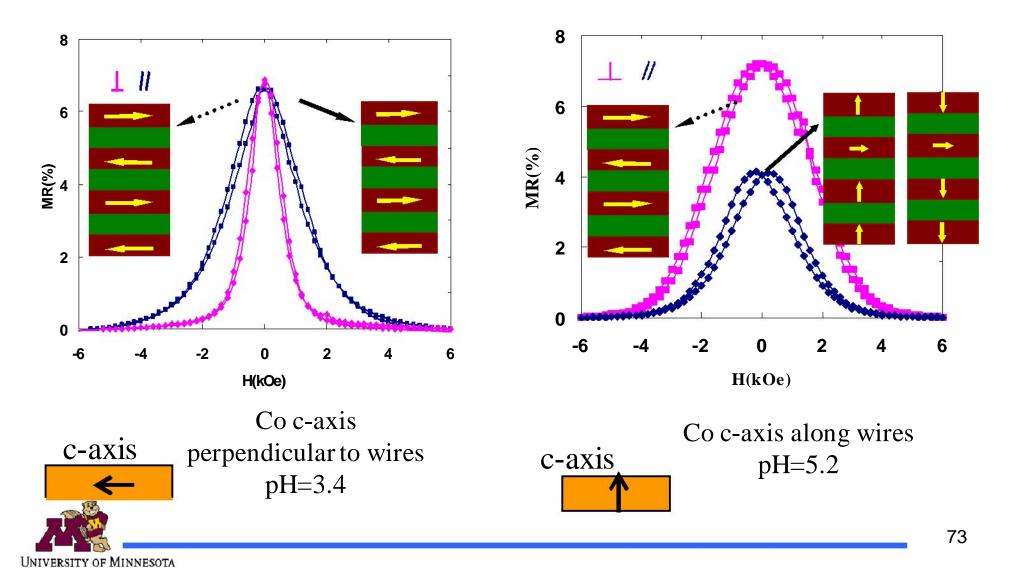


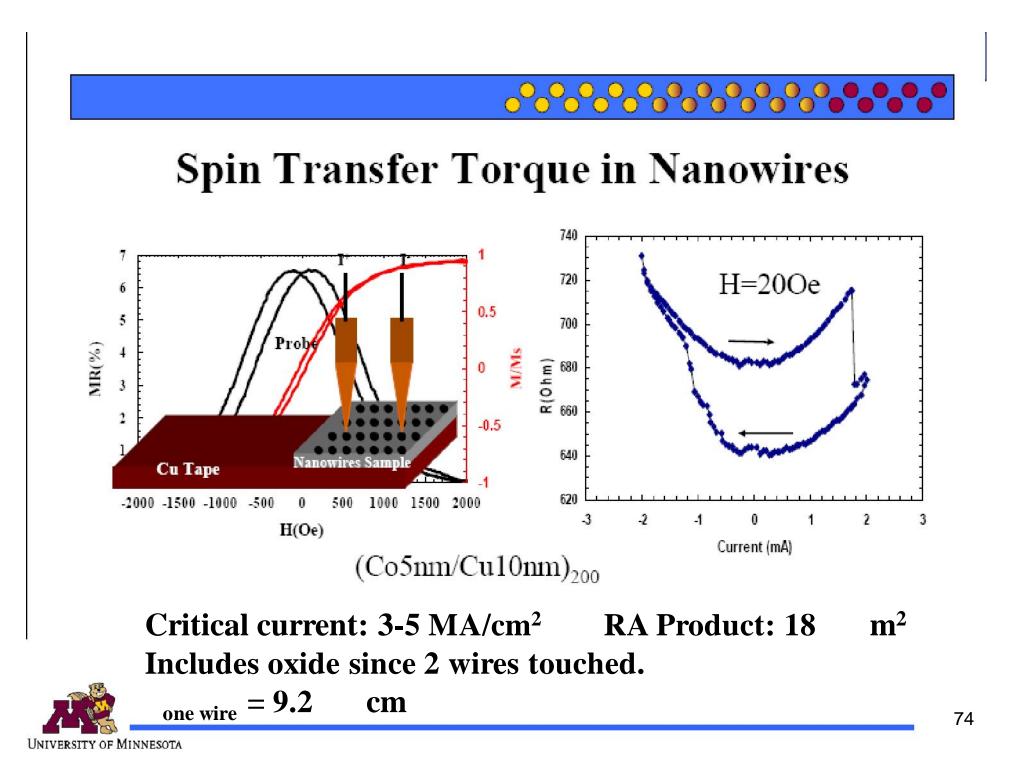
Without Lead Resistance:

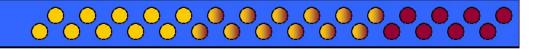
- •At 300 K, MR=19% when Hper; MR=17% when Hpar.
- At 2 K, MR=30% when Hper; MR=26% when Hpar.



M-R Loops of Co/Cu Nanowires Vary with Magnetic Anisotropies

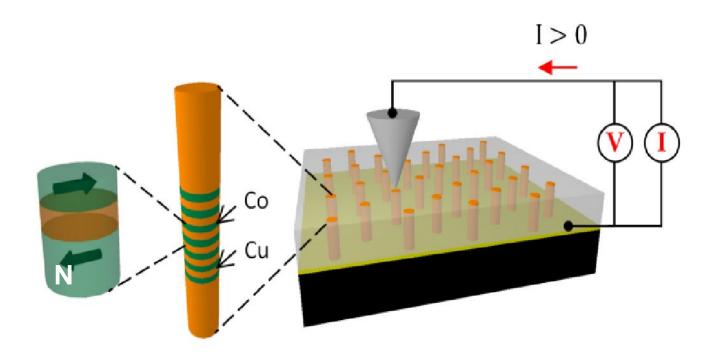






STT Measurement Setup

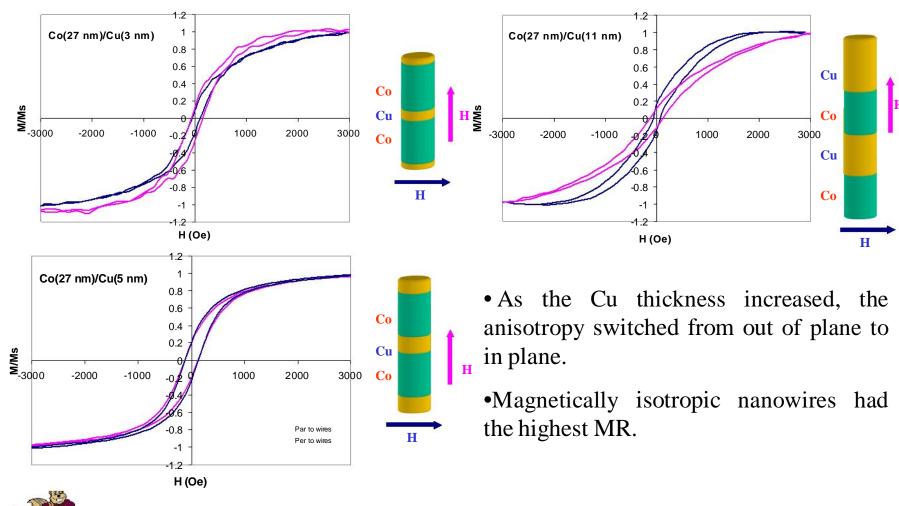
 \emptyset A conductive AFM tip was used to measure STT





10nm diameter multilayers

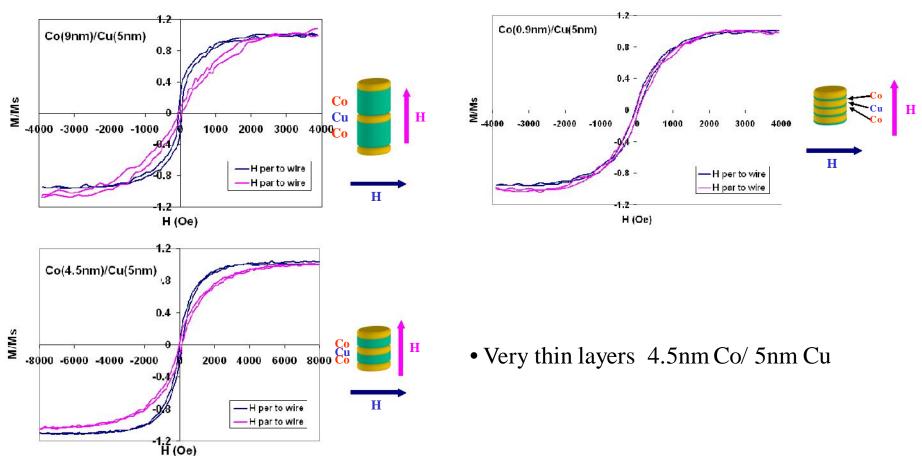
300*[Co(27 nm)/Cu(X nm)]



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Hysteresis Loop with Different Co Thickness

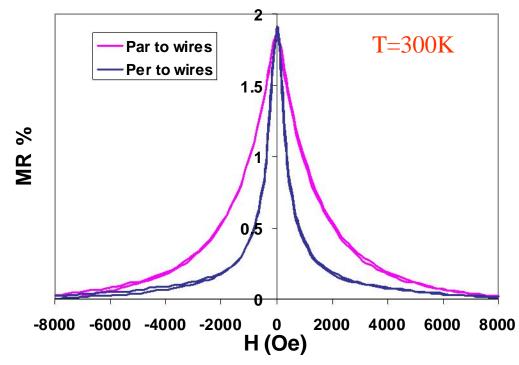
300*[Co(X nm)/Cu(5 nm)]





GMR -- Thinner Co Thickness

Sample: 300*[Co(4.5nm)/Cu(5nm)]



[•] MR=18% w/o lead R at 300K

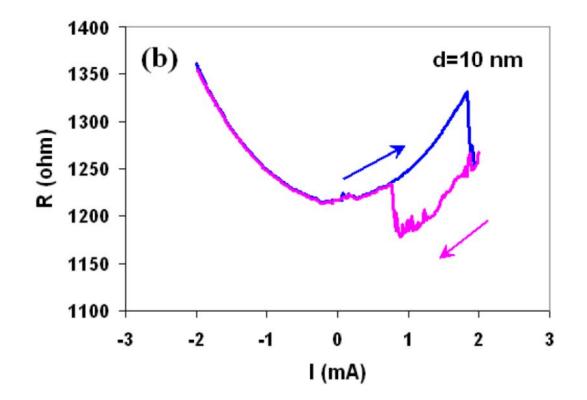
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- small diameter nanopores (10nm)

-up to 18% magnetoresistance (for Cu5nm/Co4.5nm if lead R subtracted)

-R ~ 10hm/nm for 10nm diameter wires

STT: 10-nm diameter multilayers

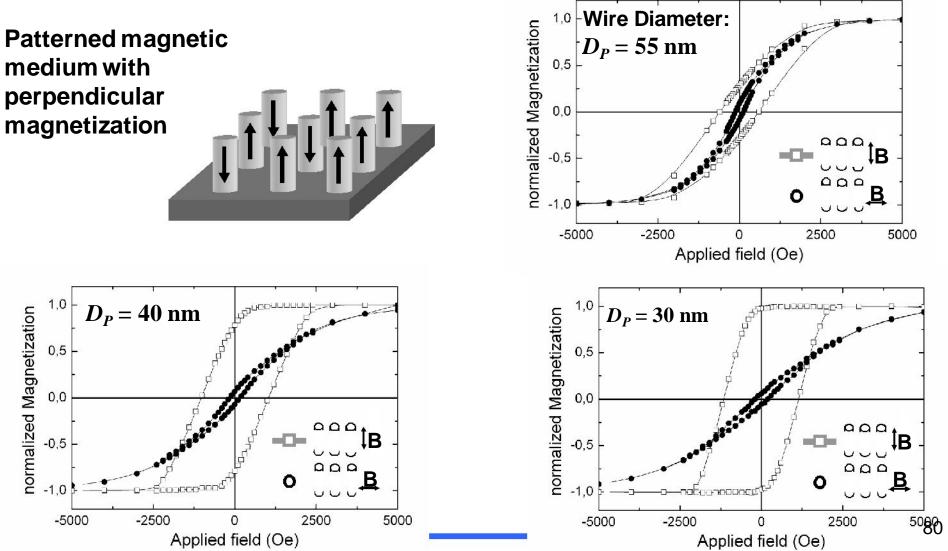


 $J_c: 20 \times 10^6 \text{A/cm}^2 \quad 8\% \text{ MR} \quad \text{RA Product: } 13 \quad \text{m}^2$ $Without \text{ leads: } 16\% \text{ MR} \quad \text{RA} \sim 6 \quad \text{m}^2$ UNIVERSITY OF MINNESOTA



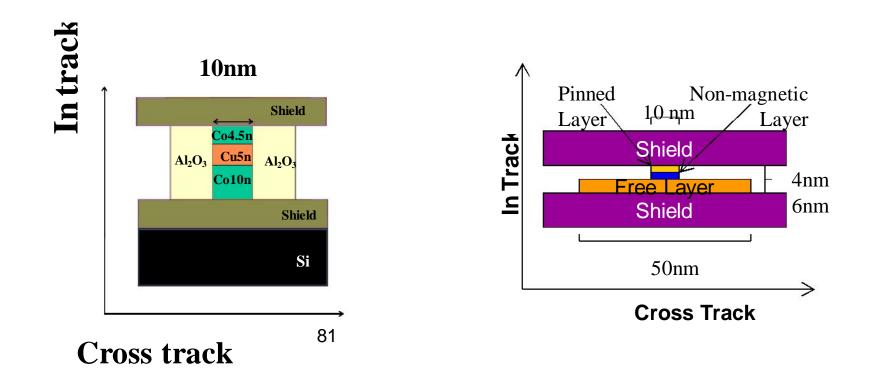
Back to Hard Drives where we started

Nielsch from Hamburg Univ, Germany





Read Heads- Trilayers



Stadler/Victora Nano Letters 2012

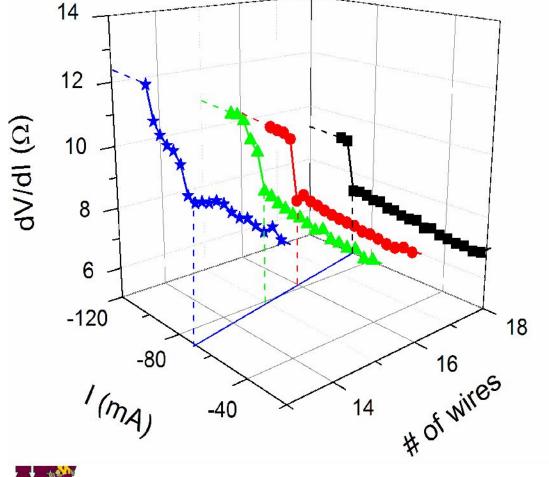


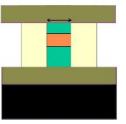
Trilayers (Co 10nm, Cu 5nm, Co 15nm)

Total resistance changes with probe pressure-

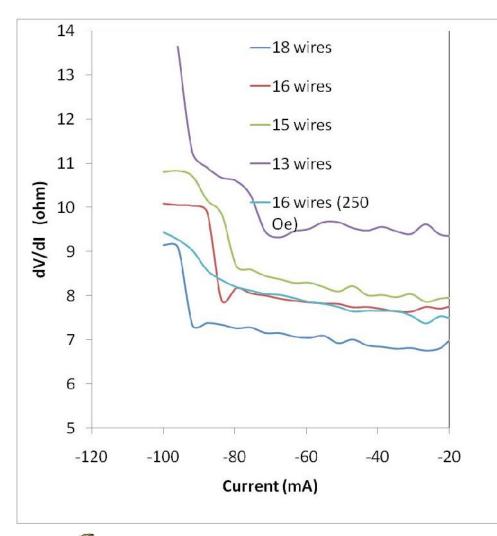
Can use it to get R of single wires?







Raw Data- Current swept negative

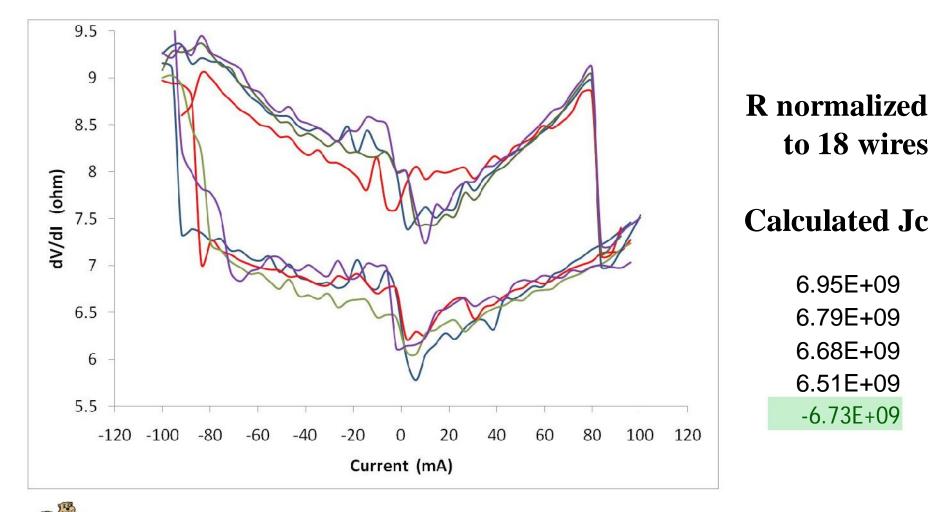


Ø R decreased probe pressure increased

- Ø Using integer values of # wires, R_{single wire} can be found
- Ø 190nm wires = 117 3x resistivity of bulk

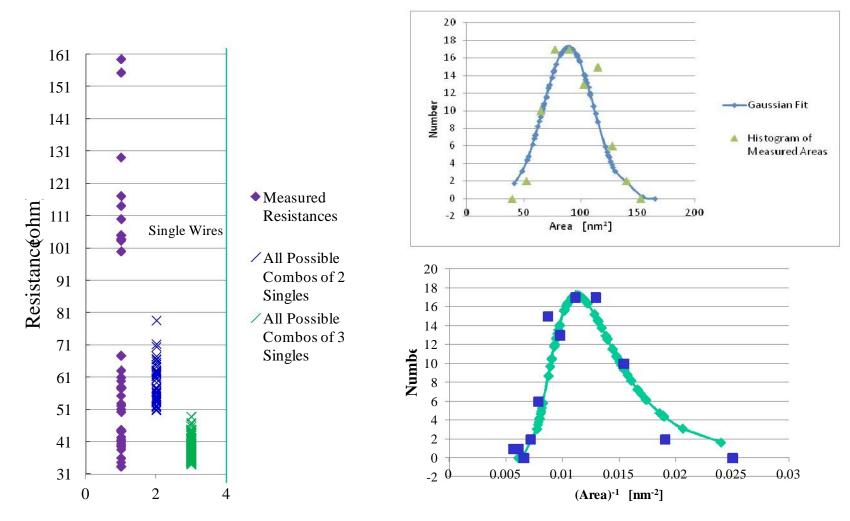


Critical Current Density agrees

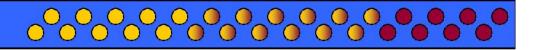




Resistivity of Single 10nm Nanowires







Review

Ø Motivation: Memory Applications

- **§** Hard drives: media and heads
- **§** Random Access Memories

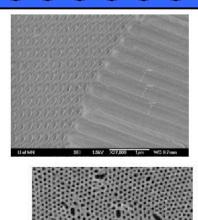
Ø Fabrication Techniques

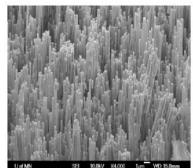
Ø Measuring Magnetoresistive Elements

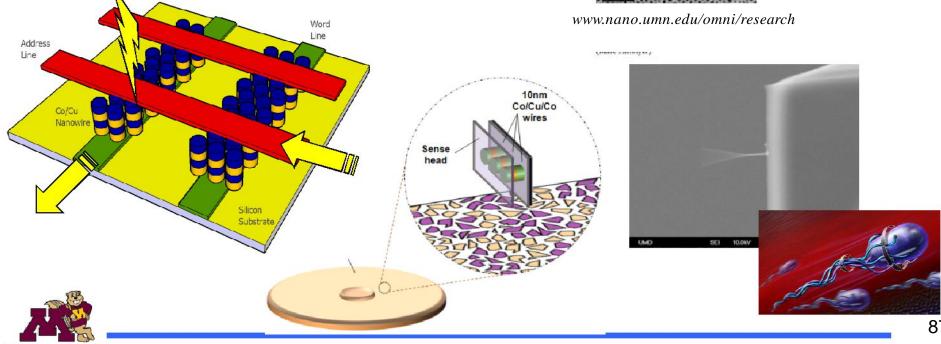


Applications

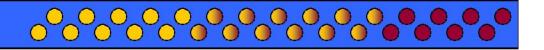
- § Recording
 - Read Sensors
 - Bit patterned media (BPM)
- **§** Random Access Memory (RAM)
- § Cilia (NEMS)
- **§** Biomagnetics







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